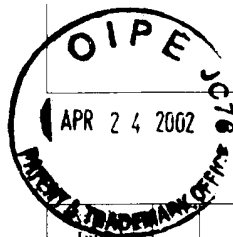


FORM PTO 1449  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY DOCKET NO. <b>GRE001</b>	SERIAL NO. <b>09/823,992</b>
	APPLICANT <b>GREEN ET AL.</b>	
	FILING DATE <b>April 3, 2001</b>	GROUP <b>2877</b>



### U.S. Patent Documents

Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate
BES	4,771,172	09/88	WEBER-GRABAU ET AL.			
BES	5,107,109	04/92	STAFFORD, JR. ET AL.			
BES	5,468,957	11/95	FRANZEN			
BES	5,572,022	11/96	SCHWARTZ ET AL.			
BES	6,080,985	06/00	WELKIE ET AL.			

### Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation	
						Yes	No
BES	63-279,555	11/88	JP				
BES	04-066,862	03/92	JP				
BES	WO98/50941	11/98	PCT				
BES	905,743	03/99	EP				
BES	2000-048764	04/00	JP				
BES	2000-082439	05/00	JP				
BES	2000-277050	10/00	JP				

### Other Documents (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)

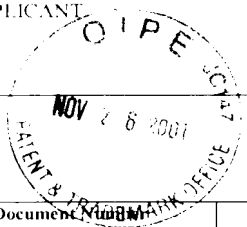
BES	Stoffels et al., Intl. J. Mass Spectrom. and Ion Phys., "An Ion Detecting and Measuring System with Wide Dynamic Range" Vol. 28, pp 159-169, 1978.
BES	Yost et al., 35 <sup>th</sup> ASMS Conference on Mass Spectrometry and Allied Topics, "Picogram to Microgram Analysis by Gas Chromatography/Ion Trap Mass Spectrometry", pp 789-790, May 24-29, 1987.

Examiner <b>Bernard Souw</b>	Date Considered <b>06/28/03</b>
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Examiner: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; Draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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### U.S. Patent Documents

Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate
<i>RES</i>	5,747,800	05/98	YANO ET AL.			

### Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation Yes No

### Other Documents (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)


Examiner <i>Bernard Souw</i>	Date Considered <i>06/28/03</i>
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